

Notice of References Cited	Application/Control No. 10/608,157	Applicant(s)/Patent Under Reexamination INAO ET AL.	
	Examiner karen masih	Art Unit 2837	Page 1 of 1


U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0030404	02-2003	Iwaji et al.	318/700
	B	US-2003/0020429	01-2003	Masaki et al.	318/727
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	 Karen Masih Primary Examiner
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